## Application/Control No. Applicant(s)/Patent Under Reexamination 09/057,838 VAN DE VEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 XIAO M. WU 2674 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-4,734,619 03-1988 Havel, Karel 313/510 Α US-В US-С D US-US-Ε US-F US-G US-Н US-US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х